## **Power MOSFET**

## −12 V, −4.3 A, µCOOL<sup>™</sup> Dual P–Channel, 2x2 mm, WDFN package

#### Features

- WDFN 2x2 mm Package with Exposed Drain Pads for Excellent Thermal Conduction
- Lowest RDS(on) in 2x2 mm Package
- Footprint Same as SC-88 Package
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- Bidirectional Current Flow with Common Source Configuration
- These are Pb–Free Devices

#### Applications

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li Ion Battery Charging and Protection Circuits
- Dual High Side Load Switch

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-12	V
Gate-to-Source Voltage	e		V <sub>GS</sub>	±8.0	V
Continuous Drain	Steady	T <sub>J</sub> = 25°C	I <sub>D</sub>	-3.5	А
Current (Note 1)	State	$T_J = 85^{\circ}C$		-2.5	
	t ≤ 5 s	T <sub>J</sub> = 25°C		-4.3	
Power Dissipation (Note 1)	Steady State	T <sub>J</sub> = 25°C	PD	1.5	W
	t ≤ 5 s	, ,		2.3	
Continuous Drain		T <sub>J</sub> = 25°C	I <sub>D</sub>	-2.4	А
Current (Note 2)	Steady	$T_J = 85^{\circ}C$		-1.7	
Power Dissipation (Note 2)	State	$T_J = 25^{\circ}C$	PD	0.7	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-20	А
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C	
Source Current (Body D	Source Current (Body Diode) (Note 2)		۱ <sub>S</sub>	-1.5	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

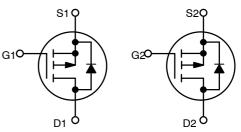
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.



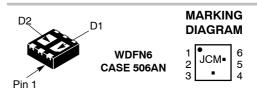
## **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
	60 mΩ @ −4.5 V	–3.0 A
	85 mΩ @ –2.5 V	–3.0 A
1011	110 mΩ @ –1.8 V	–0.7 A
–12 V	140 mΩ @ –1.5 V	–0.5 A
	190 mΩ @ −1.3 V	–0.2 A
	230 mΩ @ –1.2 V	–0.2 A

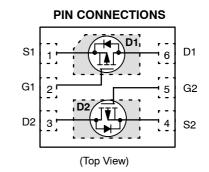


P-CHANNEL MOSFET P-CHANNEL MOSFET



JC = Specific Device Code

- M = Date Code
- = Pb–Free Package
- (Note: Microdot may be in either location)



#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Мах	Unit
SINGLE OPERATION (SELF-HEATED)			
Junction-to-Ambient - Steady State (Note 3)	R <sub>θJA</sub>	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{ hetaJA}$	54	ururur DataShoo
DUAL OPERATION (EQUALLY HEATED)			
Junction-to-Ambient - Steady State (Note 3)	R <sub>0JA</sub>	58	

Junction-to-Ambient – Steady State (Note 3)	$R_{ heta JA}$	58	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	133	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{\thetaJA}$	40	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm<sup>2</sup>, 2 oz Cu).

### **MOSFET ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -28	50 μA	-12			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = –250 μA, Ref to	o 25°C		-7.0		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$T_J = 25^{\circ}C$			-1.0	μA
		$V_{DS}$ = -12 V, $V_{GS}$ = 0 V	$T_J = 85^{\circ}C$			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±	8.0 V			±100	nA
ON CHARACTERISTICS (Note 5)	•						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -2$	50 μA	-0.35	-0.6	-0.8	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.4		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5, I_D = -3$	3.0 A		60	90	mΩ
		$V_{GS} = -2.5, I_D = -3$	3.0 A		85	120	
		$V_{GS} = -1.8, I_D = -0.000$	0.7 A		110	150	
		V <sub>GS</sub> = -1.5, I <sub>D</sub> = -0	0.5 A		140	200	
		V <sub>GS</sub> = -1.3, I <sub>D</sub> = -1			190		
		$V_{GS} = -1.2, I_D = -1.2$	0.2 A		230		
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -	-3.0 A		6.0		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE					
Input Capacitance	C <sub>ISS</sub>				467		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 M V <sub>DS</sub> = -6.0 V	ИHz,		125		
Reverse Transfer Capacitance	C <sub>RSS</sub>				79		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.5	8.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> =	–6.0 V,		0.3		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = I_D = -3.0 \text{ A}$	,		0.8		1
					-	1	-

Gate-to-Drain Charge

Gate Resistance

5. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

 $Q_{GD}$ 

 $R_{G}$ 

Ω

1.5

12.2

#### MOSFET ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	IS	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	(Note 6)			-			
Turn-On Delay Time	t <sub>d(ON)</sub>				6.6		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> =	–6.0 V,		12.3		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$\begin{array}{l} V_{GS} = -4.5 \text{ V},  V_{DD} = -6.0 \text{ V}, \\ I_{D} = -3.0 \text{ A},  R_{G} = 2.0 \ \Omega \end{array}$			14	www.I	DataSheet4
Fall Time	t <sub>f</sub>				16.2		, and a second
DRAIN-SOURCE DIODE CHARA	CTERISTICS			-			
Forward Recovery Voltage	V <sub>SD</sub>		$T_J = 25^{\circ}C$		-0.7	-1.0	V
		$V_{GS} = 0 V, I_{S} = -1.0 A$	T <sub>J</sub> = 85°C		-0.65		
Reverse Recovery Time	t <sub>RR</sub>		-		23	45	ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 V, d_{ISD}/d_t = 1$ $I_S = -1.0 A$	00 A/μs,		8.0		
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = -1.0 A			15		

10

20

nC

5. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

Q<sub>RR</sub>

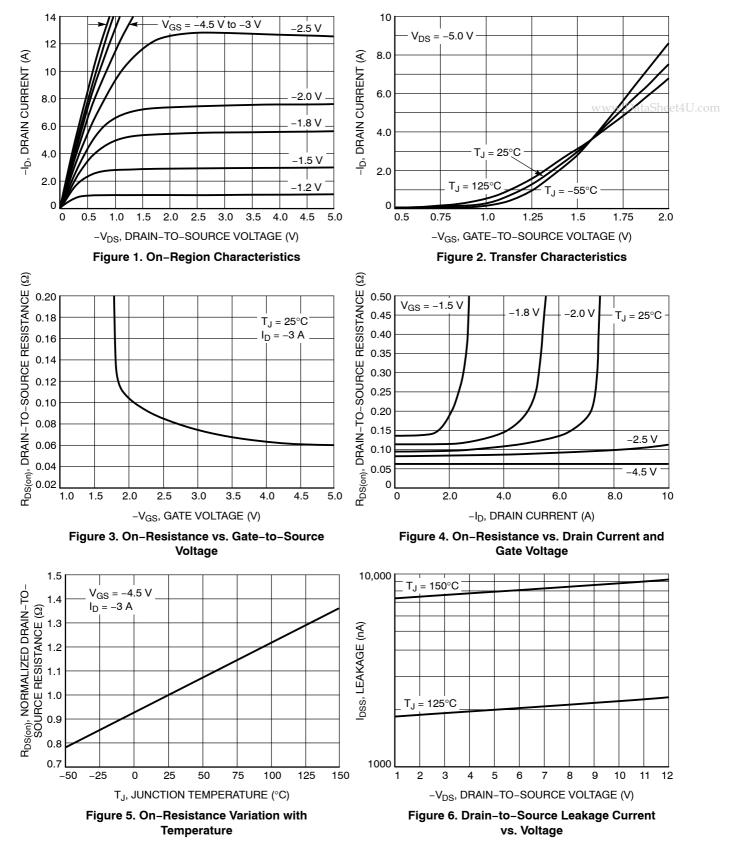
#### **ORDERING INFORMATION**

**Reverse Recovery Time** 

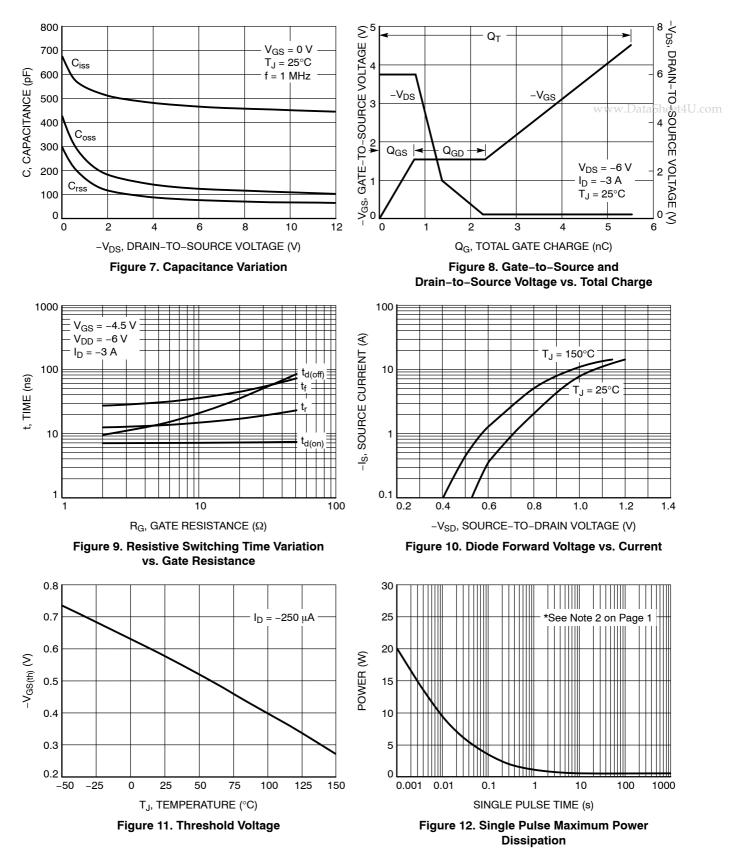
Device	Package	Shipping <sup>†</sup>
NTLJD2104PTBG	WDFN6 (Pb-Free)	3000 / Tape & Reel
NTLJD2104PTAG	WDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

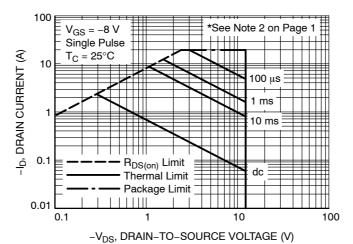




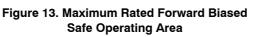
#### **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**



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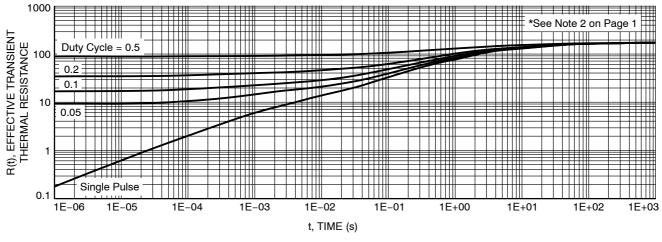
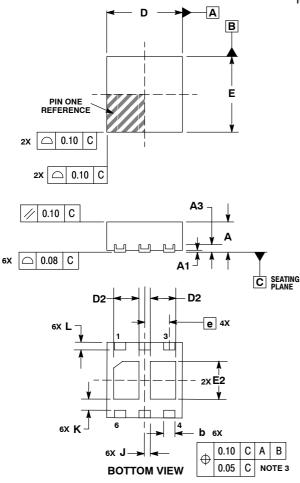


Figure 14. FET Thermal Response

#### PACKAGE DIMENSIONS

WDFN6 2x2 CASE 506AN-01 ISSUE C



NOTES:

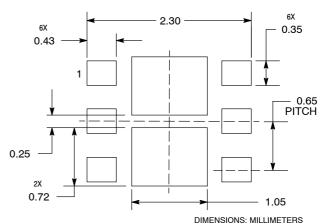
 DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION b APPLIES TO PLATED

- TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20mm FROM TERMINAL.
- 0.15 AND 0.20mm FROM TERMINAL.
  COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
A3	0.20 REF			
b	0.25	0.35		
D	2.00 BSC			
D2	0.57	0.77		
Е	2.00 BSC			
E2	0.90	1.10		
е	0.65 BSC			
K	0.25	REF		
L	0.20	0.30		
J	0.15 REF			

#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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